

### N-CHANNEL MOS FIELD EFFECT TRANSISTOR FOR SWITCHING

#### DESCRIPTION

The  $\mu$ PA620TT is a switching device which can be driven directly by a 2.5 V power source.

This device features a low on-state resistance and excellent switching characteristics, and is suitable for applications such as power switch of portable machine and so on.

#### FEATURES

- 2.5 V drive available
- Low on-state resistance
  - $R_{DS(on)1} = 38 \text{ m}\Omega \text{ MAX. (} V_{GS} = 4.5 \text{ V, } I_D = 2.5 \text{ A)}$
  - $R_{DS(on)2} = 39 \text{ m}\Omega \text{ MAX. (} V_{GS} = 4.0 \text{ V, } I_D = 2.5 \text{ A)}$
  - $R_{DS(on)3} = 54 \text{ m}\Omega \text{ MAX. (} V_{GS} = 2.5 \text{ V, } I_D = 2.5 \text{ A)}$

#### ORDERING INFORMATION

| PART NUMBER   | PACKAGE           |
|---------------|-------------------|
| $\mu$ PA620TT | 6 pin WSOF (1620) |

Marking: WA

#### ABSOLUTE MAXIMUM RATINGS ( $T_A = 25^\circ\text{C}$ )

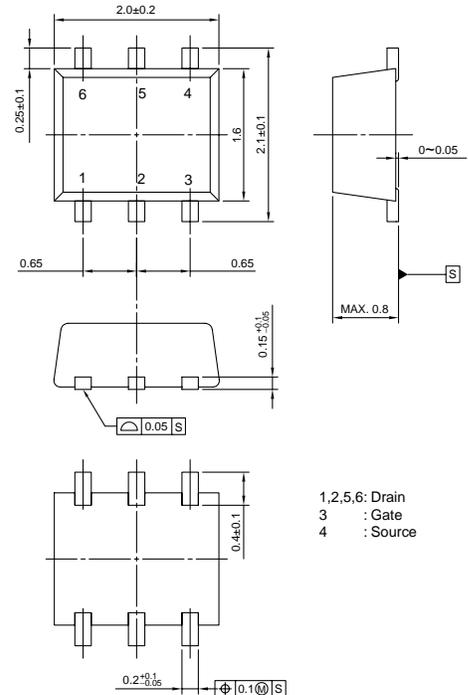
|  |                |             |                  |
|--|----------------|-------------|------------------|
| Drain to Source Voltage ( $V_{GS} = 0 \text{ V}$ ) | $V_{DSS}$      | 20          | V                |
| Gate to Source Voltage ( $V_{DS} = 0 \text{ V}$ )  | $V_{GSS}$      | $\pm 12$    | V                |
| Drain Current (DC) ( $T_A = 25^\circ\text{C}$ )    | $I_{D(DC)}$    | $\pm 5.0$   | A                |
| Drain Current (pulse) <sup>Note1</sup>             | $I_{D(pulse)}$ | $\pm 20$    | A                |
| Total Power Dissipation                            | $P_{T1}$       | 0.2         | W                |
| Total Power Dissipation <sup>Note2</sup>           | $P_{T2}$       | 1.5         | W                |
| Channel Temperature                                | $T_{ch}$       | 150         | $^\circ\text{C}$ |
| Storage Temperature                                | $T_{stg}$      | -55 to +150 | $^\circ\text{C}$ |

**Notes** 1.  $PW \leq 10 \mu\text{s}$ , Duty Cycle  $\leq 1\%$

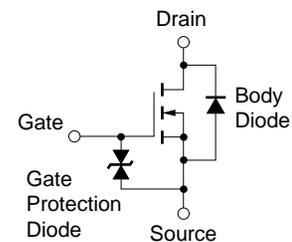
2. Mounted on FR-4 board of  $5000 \text{ mm}^2 \times 1.1 \text{ mm}$ ,  $t \leq 5 \text{ sec}$ .

**Remark** The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

#### PACKAGE DRAWING (Unit: mm)



#### EQUIVALENT CIRCUIT

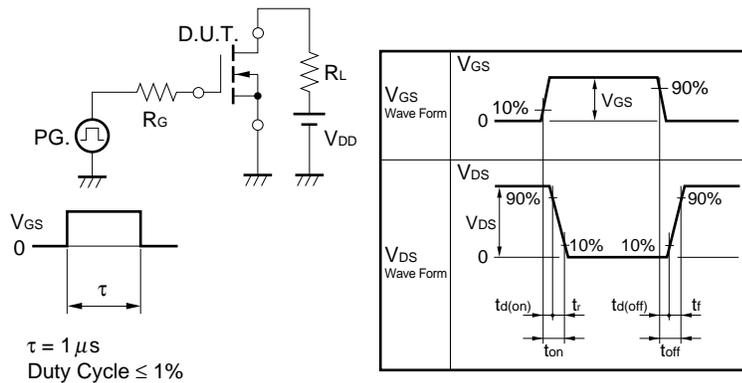


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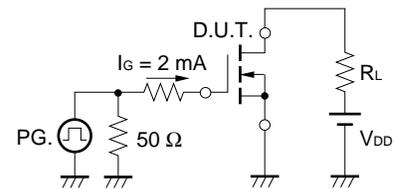
**ELECTRICAL CHARACTERISTICS (TA = 25°C)**

| CHARACTERISTICS                     | SYMBOL        | TEST CONDITIONS                                 | MIN. | TYP. | MAX. | UNIT |
|-------------------------------------|---------------|---|------|------|------|------|
| Zero Gate Voltage Drain Current     | $I_{DSS}$     | $V_{DS} = 20\text{ V}, V_{GS} = 0\text{ V}$     |      |      | 10   | μA   |
| Gate Leakage Current                | $I_{GSS}$     | $V_{GS} = \pm 12\text{ V}, V_{DS} = 0\text{ V}$ |      |      | ±10  | μA   |
| Gate Cut-off Voltage                | $V_{GS(off)}$ | $V_{DS} = 10\text{ V}, I_D = 1.0\text{ mA}$     | 0.5  | 1.0  | 1.5  | V    |
| Forward Transfer Admittance         | $ y_{fs} $    | $V_{DS} = 10\text{ V}, I_D = 2.5\text{ A}$      | 3.0  | 6.0  |      | S    |
| Drain to Source On-state Resistance | $R_{DS(on)1}$ | $V_{GS} = 4.5\text{ V}, I_D = 2.5\text{ A}$     |      | 30   | 38   | mΩ   |
|                                     | $R_{DS(on)2}$ | $V_{GS} = 4.0\text{ V}, I_D = 2.5\text{ A}$     |      | 31   | 39   | mΩ   |
|                                     | $R_{DS(on)3}$ | $V_{GS} = 2.5\text{ V}, I_D = 2.5\text{ A}$     |      | 40   | 54   | mΩ   |
| Input Capacitance                   | $C_{iss}$     | $V_{DS} = 10\text{ V}$                          |      | 450  |      | pF   |
| Output Capacitance                  | $C_{oss}$     | $V_{GS} = 0\text{ V}$                           |      | 130  |      | pF   |
| Reverse Transfer Capacitance        | $C_{rss}$     | $f = 1.0\text{ MHz}$                            |      | 90   |      | pF   |
| Turn-on Delay Time                  | $t_{d(on)}$   | $V_{DD} = 10\text{ V}, I_D = 2.5\text{ A}$      |      | 36   |      | ns   |
| Rise Time                           | $t_r$         | $V_{GS} = 4.0\text{ V}$                         |      | 210  |      | ns   |
| Turn-off Delay Time                 | $t_{d(off)}$  | $R_G = 10\text{ }\Omega$                        |      | 150  |      | ns   |
| Fall Time                           | $t_f$         |   |      | 200  |      | ns   |
| Total Gate Charge                   | $Q_G$         | $V_{DD} = 16\text{ V}$                          |      | 5.5  |      | nC   |
| Gate to Source Charge               | $Q_{GS}$      | $V_{GS} = 4.0\text{ V}$                         |      | 1.0  |      | nC   |
| Gate to Drain Charge                | $Q_{GD}$      | $I_D = 5.0\text{ A}$                            |      | 2.8  |      | nC   |
| Body Diode Forward Voltage          | $V_{F(S-D)}$  | $I_F = 5.0\text{ A}, V_{GS} = 0\text{ V}$       |      | 0.87 |      | V    |

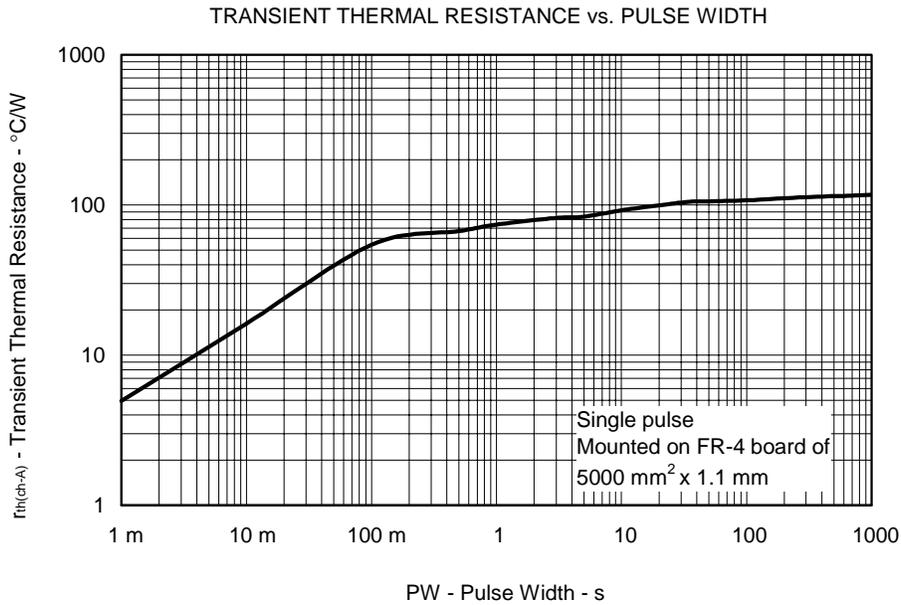
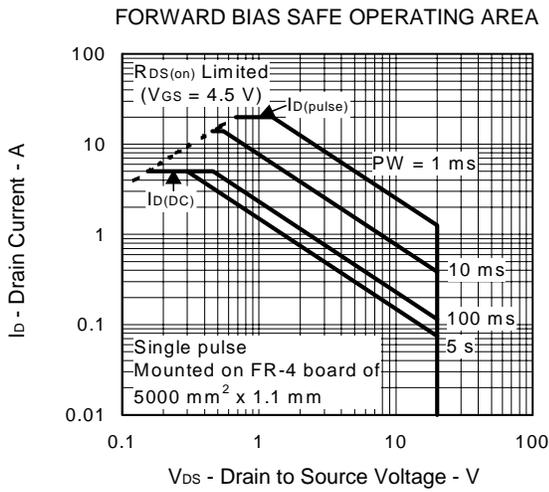
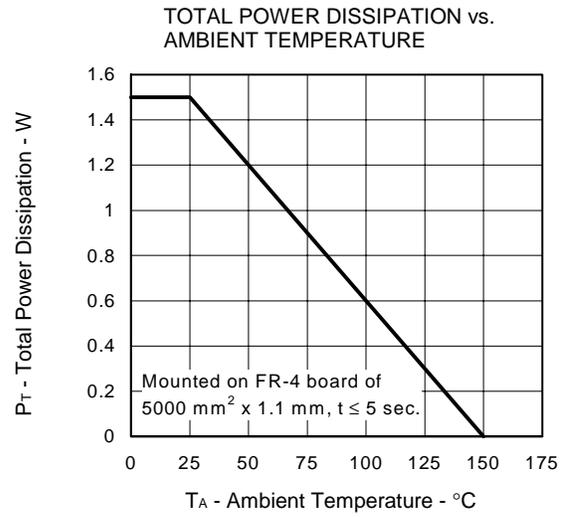
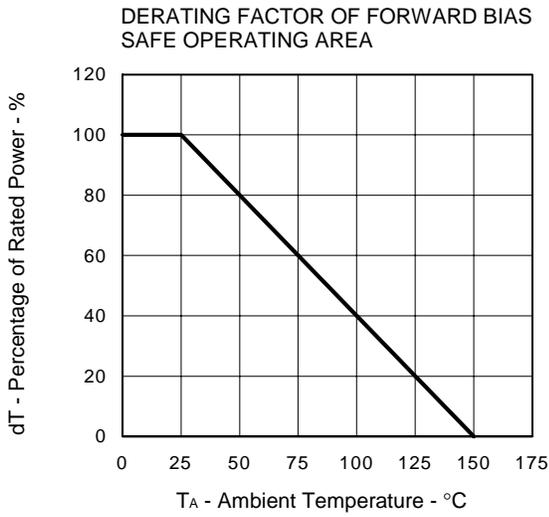
**TEST CIRCUIT 1 SWITCHING TIME**



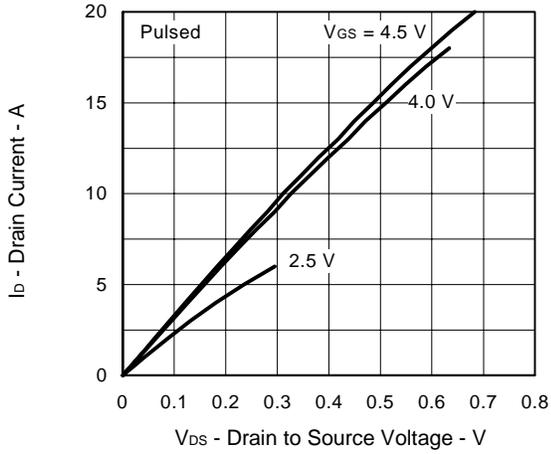
**TEST CIRCUIT 2 GATE CHARGE**



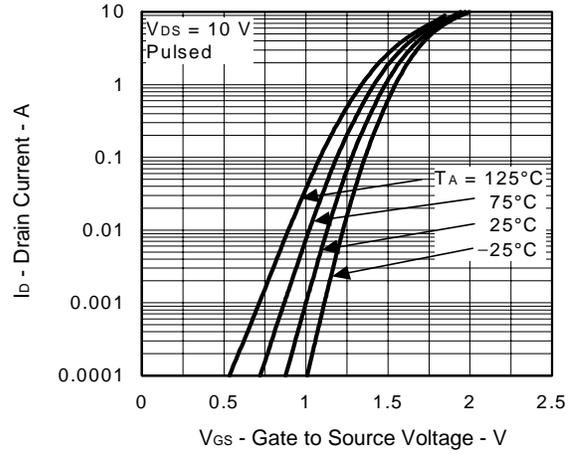
TYPICAL CHARACTERISTICS (T<sub>A</sub> = 25°C)



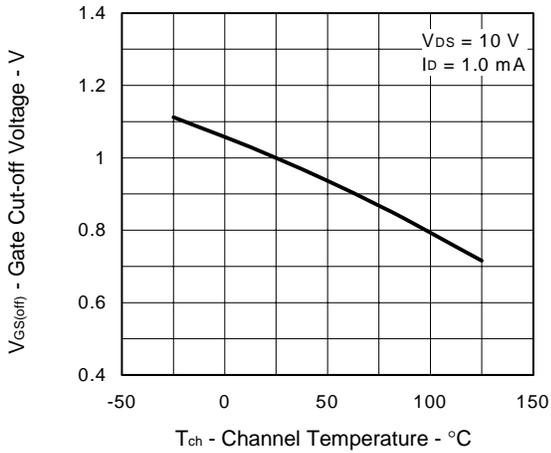
DRAIN CURRENT vs. DRAIN TO SOURCE VOLTAGE



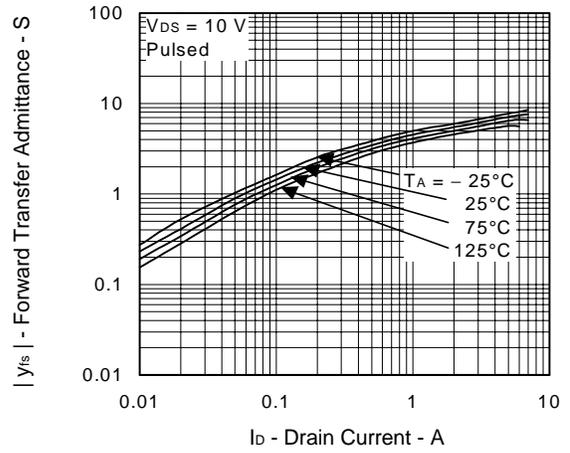
FORWARD TRANSFER CHARACTERISTICS



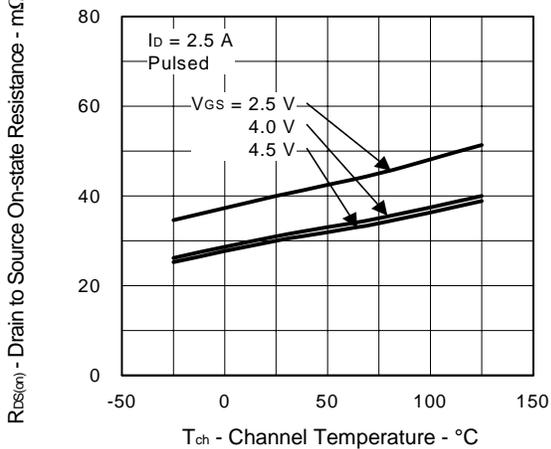
GATE CUT-OFF VOLTAGE vs. CHANNEL TEMPERATURE



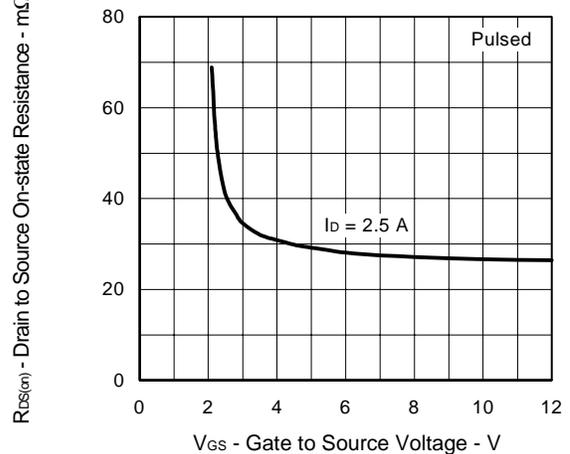
FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT

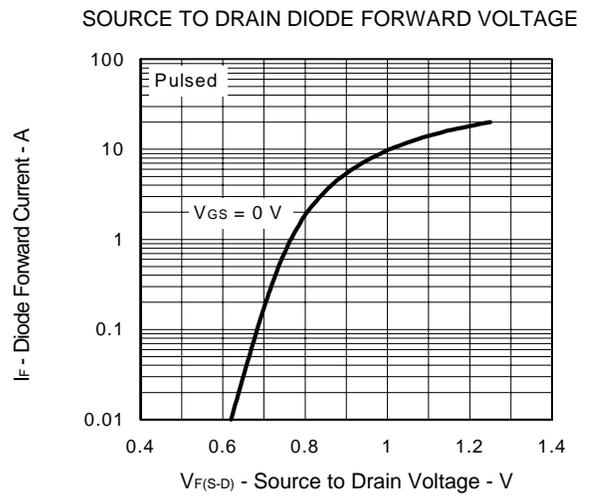
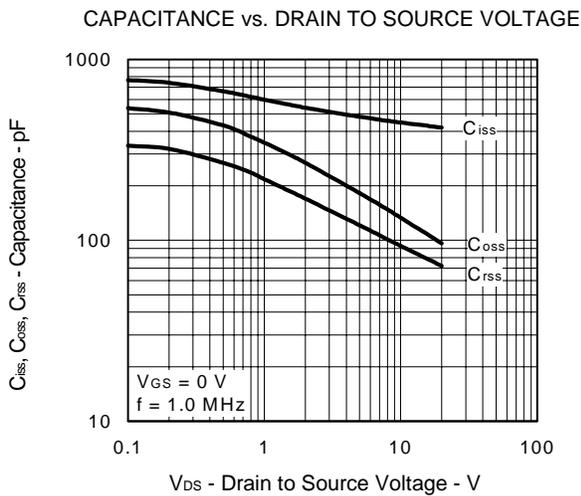
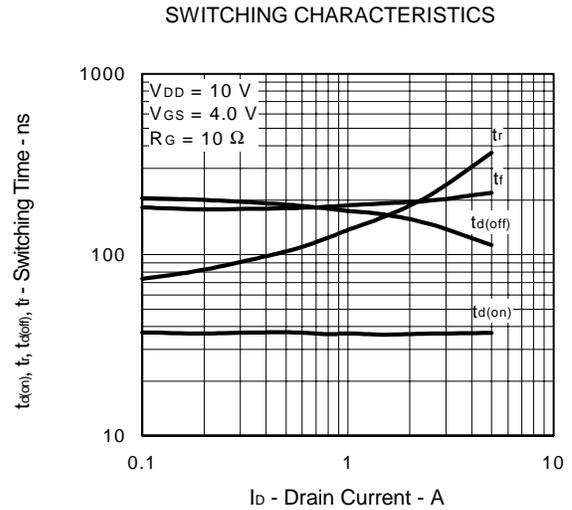
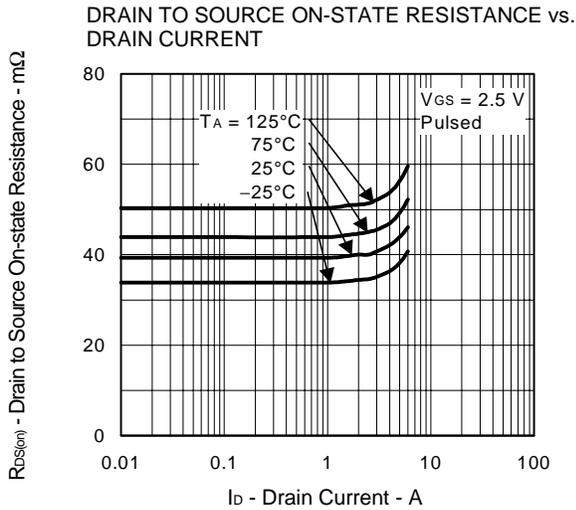
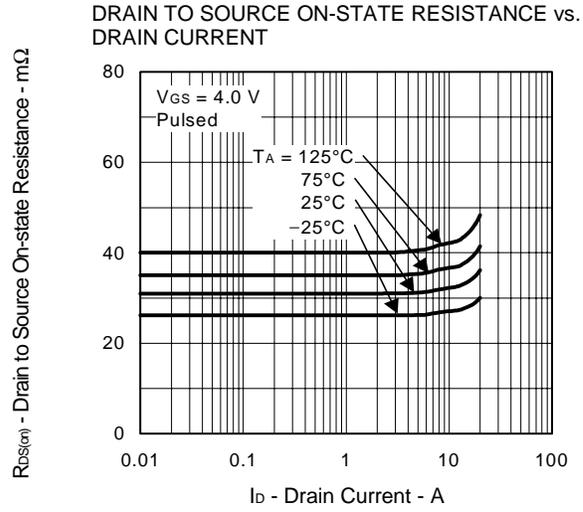
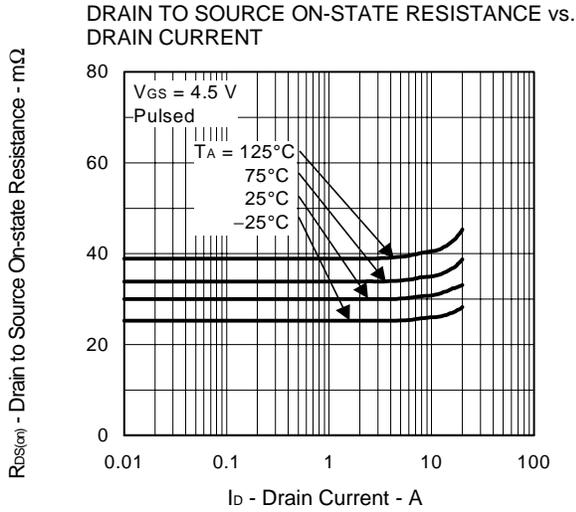


DRAIN TO SOURCE ON-STATE RESISTANCE vs. CHANNEL TEMPERATURE

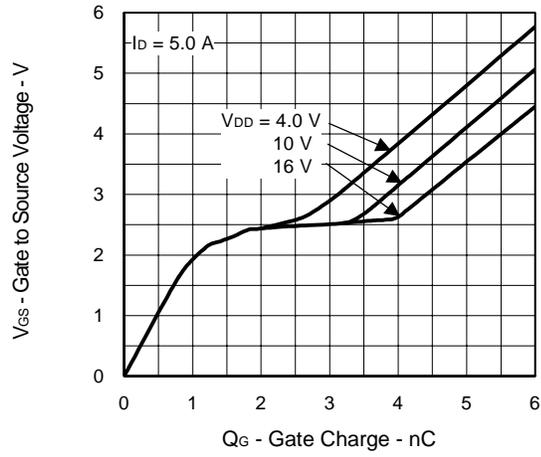


DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE





DYNAMIC INPUT/OUTPUT CHARACTERISTICS



[MEMO]

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